

GD54/74S20

DUAL 4-INPUT POSITIVE NAND GATES

Description

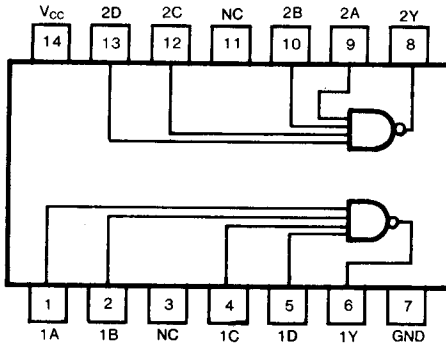
This device contains two independent 4-input NAND gates. It performs the Boolean functions, $Y = \overline{A \cdot B \cdot C \cdot D}$ or $Y = \overline{A} + \overline{B} + \overline{C} + \overline{D}$ in positive logic.

Function Table (each gate)

| INPUTS | | OUTPUT |
|--------|----|--------|
| A | N* | Y |
| L | L | H |
| H | L | H |
| L | H | H |
| H | H | L |

*N = B · C · D

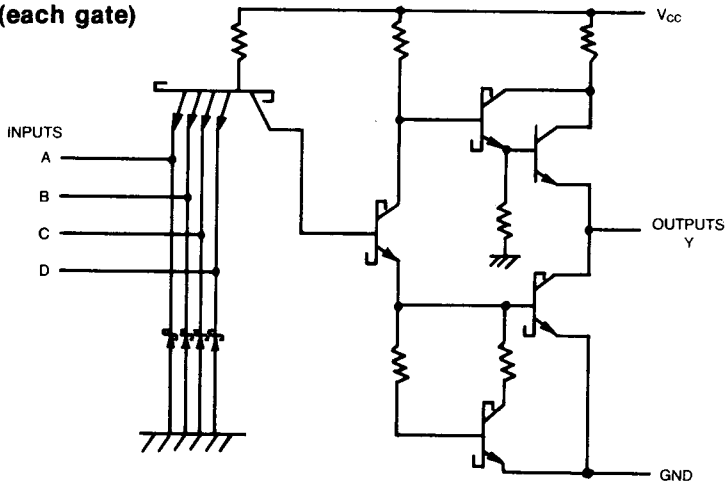
Pin Configuration



NC: No internal connection

Suffix-Blank: Plastic Dual In Line Package
 Suffix-J : Ceramic Dual In Line Package

Schematic (each gate)



Absolute Maximum Ratings

- Supply voltage, V_{CC} 7V
- Input voltage 5.5V
- Operating free-air temperature range 54S -55°C to 125°C
 74S 0°C to 70°C
- Storage temperature range -65°C to 150°C

Recommended Operating Conditions

| SYMBOL | PARAMETER | | MIN | NOM | MAX | UNIT |
|-----------------|--------------------------------|----|------|-----|------|------|
| V _{CC} | Supply voltage | 54 | 4.5 | 5 | 5.5 | V |
| | | 74 | 4.75 | 5 | 5.25 | |
| I _{OH} | High-level output current | | | | -1 | mA |
| I _{OL} | Low-level output current | | | | 20 | mA |
| T _A | Operating free-air temperature | 54 | -55 | | 125 | °C |
| | | 74 | 0 | | 70 | |

Electrical Characteristics over recommended operating free-air temperature range (unless otherwise noted)

| SYMBOL | PARAMETER | TEST CONDITIONS | MIN | TYP (Note 1) | MAX | UNIT | |
|------------------|--|--|----------------------|-----------------|------|------|----|
| V _{IH} | High-level input voltage | | 2 | | | V | |
| V _{IL} | Low-level input voltage | | 54 | | 0.8 | V | |
| | | | 74 | | 0.8 | | |
| V _{IK} | Input clamp voltage | V _{CC} =Min, I _I =-18mA | | | -1.2 | V | |
| V _{OH} | High-level output voltage | V _{CC} =Min, V _{IL} =Max I _{OH} =Max | 54 | 2.5 | 3.4 | V | |
| | | | 74 | 2.7 | 3.4 | | |
| V _{OL} | Low-level output voltage | V _{CC} =Min, V _{IH} =Min I _{OL} =Max | | | 0.5 | V | |
| I _I | Input current at maximum input voltage | V _{CC} =Max, V _I =5.5V | | | 1 | mA | |
| I _{IH} | High-level input current | V _{CC} =Max, V _I =2.7V | | | 50 | μA | |
| I _{IL} | Low-level input current | V _{CC} =Max, V _I =0.5V | | | -2 | mA | |
| I _{OS} | Short-circuit output current | V _{CC} =Max (Note 2) | -40 | | -100 | mA | |
| I _{CCH} | Supply current | Total with outputs high | V _{CC} =Max | | 5 | 8 | mA |
| I _{CCL} | | Total with outputs low | V _{CC} =Max | | 10 | 18 | mA |

Note 1: All typical values are at V_{CC}=5V, T_A=25°C.

Note 2: Not more than one output should be shorted at a time, and the duration should not exceed one second.

Switching Characteristics, V_{CC} = 5V, T_A = 25°C

| SYMBOL | PARAMETER | TEST CONDITION# | MIN | TYP | MAX | UNIT |
|------------------|--|--|-----|-----|-----|------|
| t _{PLH} | Propagation delay time, low-to-high-level output | C _L = 15pF, R _L = 280Ω | | 3 | 4.5 | ns |
| t _{PHL} | Propagation delay time, high-to-low-level output | | | 3 | 5 | |

*For load circuit and voltage waveforms, see page 3-12.